

Search Notes

Application/Control No.

10/648,773

Examiner

Jim Vannucci

Applicant(s)/Patent under
Reexamination

TANAKA, AKIRA

Art Unit

2828

SEARCHED

Class	Subclass	Date	Examiner
372	46	5/26/2005	JV

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
band gap, window region, active layer, emission region	5/26/2005	JV